

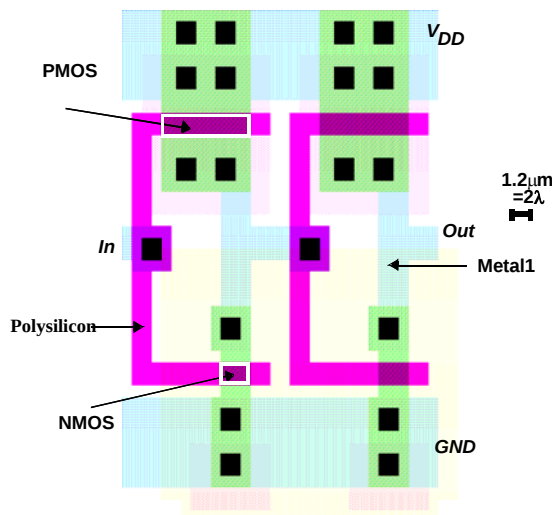
CMOS INVERTER

dynamic behavior (performance)

- Capacitances
- (Dis)charge times
- Delay

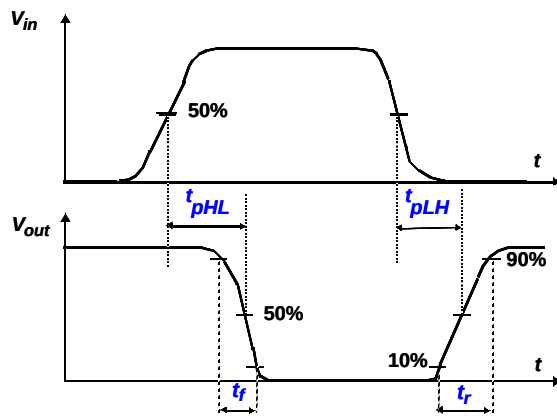


CMOS Inverters



- What causes the delay?
- Where are the capacitances?
- Which capacitances determine t_p ?
- How can we estimate (dis)charge times?

Delay Definitions

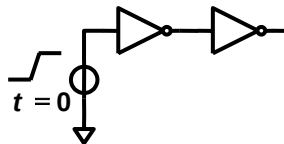


$$t_p = \frac{1}{2}(t_{pHL} + t_{pLH})$$



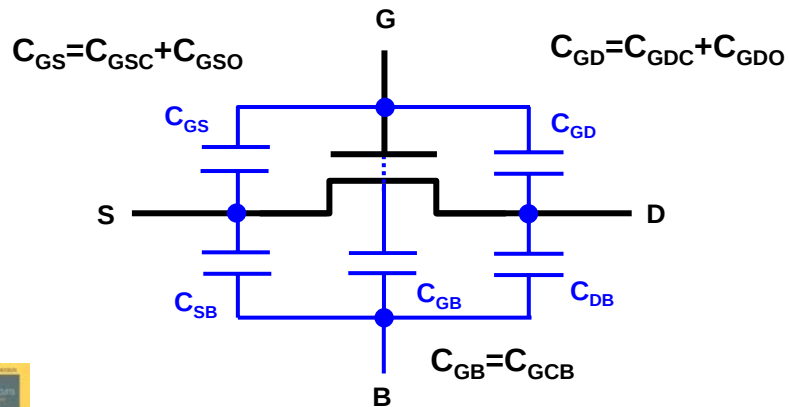
t_p : property of gate
 t_r, t_f : property of signal

CMOS Inverter Rise/Fall Delay



- Goal: determine t_{pLH} , t_{pHL} , t_r , t_f
- First: compute relevant capacitances
- Second: compute the time for (dis)charging those capacitances

MOS Capacitance Model

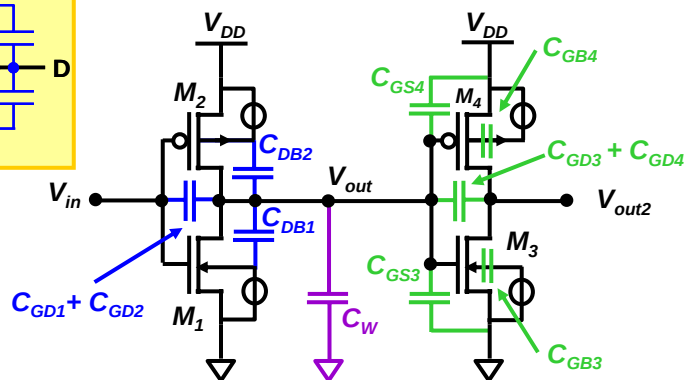
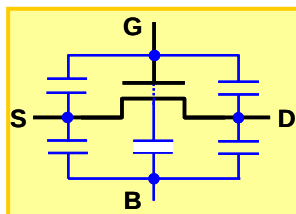


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Inverter Cascade Capacitances



- $C_{GD1,2}, C_{DB1,2}$: drain (output) of driving inverter
- $C_{GS3,4}, C_{GD3,4}, C_{GB3,4}$: gate (input) of loading inverter (fanout capacitances)
- C_W : parasitic (wire) capacitances

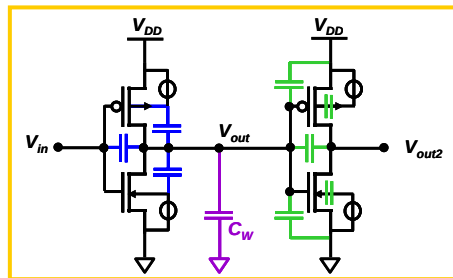
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Manual Delay Estimation

- Now, we (sort of) know the capacitances that determine inverter delay
- (Drastic) simplification needed for hand calculation
- Replace these C's by one lumped linear capacitance connected to ground.
- This is an approximation, because:
 - Most C's are non-linear
 - They are not between V_{out} and a fixed potential

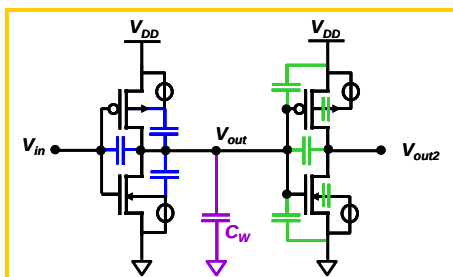


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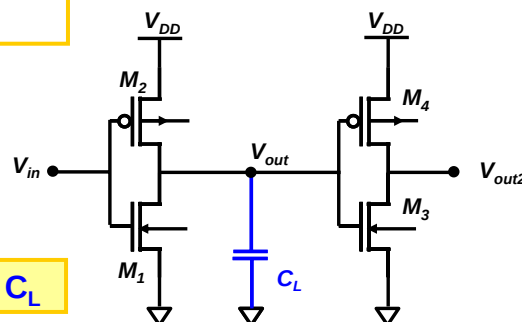
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Lumped Capacitance Model



For Manual Delay Estimation



Next: How to estimate C_L

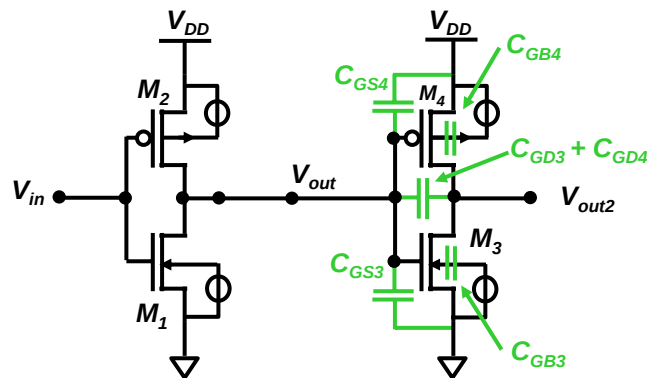
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Gate Caps of Loading Inverter

- Consider 3 groups of caps separately
- Begin with gate caps of loading inverter



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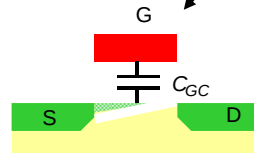
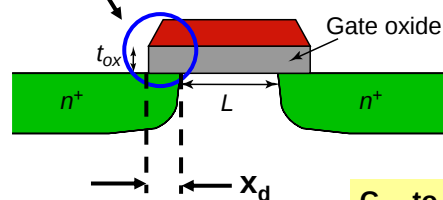
Gate Caps of Loading Inverter (2)

$$C_G = C_{GS} + C_{GD} + C_{GB} \quad \text{when in off-state (no channel)}$$

$$= C_{GCS} + C_{GSO}$$

Part of gate-channel cap attributed to source, depends on level of saturation

$$C_{GSO} = C_{GDO} = C_{ox} x_d W = C_o W$$



C_{GD} to be decomposed similarly as C_{GS}

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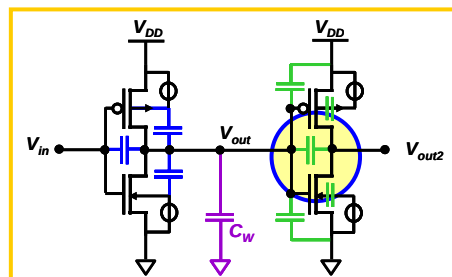
Gate Caps of Loading Inverter (3)

$$C_G = C_{GS} + C_{GD} + C_{GB}$$

- C_{GD} connected between V_{out} and V_{out2}
- Swing on V_{out2} is (almost) zero for 50% swing of V_{out}
- C_{GS} and C_{GB} between V_{out} and fixed potential

Conclusion

C_G of loading inverter can be considered between V_{out} and fixed potential



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Gate Caps of Loading Inverter (4)

$$\begin{aligned} C_G &= C_{GS} + C_{GD} + C_{GB} \\ &= C_{GCS} + C_{GSO} + C_{GCD} + C_{GDO} + C_{GB} \end{aligned}$$

- **Overlap capacitances** are linear
- **'active' capacitances** are highly non-linear but....
- their sum is much more linear, given by $C_{ox} W L$

Conclusions

1. C_G between V_{out} and fixed potential
2. $C_G = C_{ox} W L + 2C_{ox} x_d W$

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Capacitances in 0.25 μm CMOS process

	C_{ox} (fF/ μm^2)	C_o (fF/ μm)	C_j (fF/ μm^2)	m_j	ϕ_b (V)	C_{jsw} (fF/ μm)	m_{jsw}	ϕ_{bsw} (V)
NMOS	6	0.31	2	0.5	0.9	0.28	0.44	0.9
PMOS	6	0.27	1.9	0.48	0.9	0.22	0.32	0.9

```
simulator lang=spectre
model nmos osim3v3
+version=3.1
+type =n
+tnom = 25
+XW = 0
```

```
x1 = 3e-8
tox = 5.8e-9
```

```
...
+mj = 0.4960069 pb = 0.9173808 cjsw = 2.751528e-10
+mjsw = 0.443145 pbsw = 0.9173808 cjswg = 2.135064e-10
...
+cgdo = 3.11e-10 cgso = 3.11e-10 capmod = 0
...
```

$$C_{ox} = \frac{\epsilon_r \epsilon_0}{t_{ox}} = \frac{3.9 \times 8.85 \times 10^{-12}}{5.8 \times 10^{-9}} = 5.95 \text{ fF}/\mu\text{m}$$

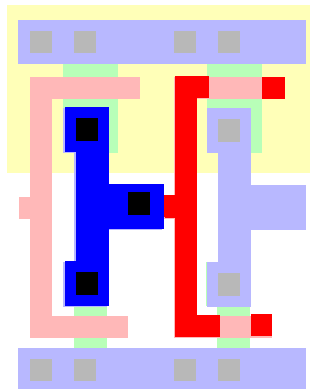


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Wire Capacitances



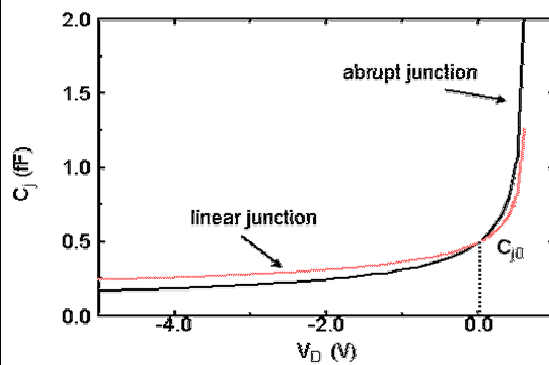
- (Almost) perfectly linear
- Usually computed by layout-to-circuit extraction
- Coupling capacitances usually considered grounded for manual calculation
- Highlighted part connected to V_{out} and not accounted for with device cap
- Wire (a.k.a. interconnect) capacitance
- Connected between V_{out} and (to first order) fixed potential of bulk

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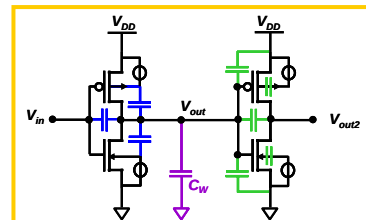
Drain Caps of Driving Inverter



- Junction capacitance C_{DB}
- Highly Non-linear

$$C_j = \frac{C_{j0}}{\left(1 - \frac{V_D}{\phi_0}\right)^m}$$

$m=0.5$: abrupt junction
 $m=0.33$: linear junction



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Junction Caps in 0.25 μm CMOS process

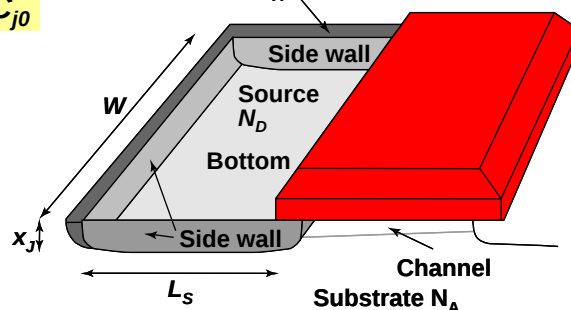
	C_{ox} (fF/ μm^2)	C_o (fF/ μm)	C_j (fF/ μm^2)	m_j	ϕ_b (V)	C_{jsw} (fF/ μm)	m_{jsw}	ϕ_{bsw} (V)
NMOS	6	0.31	2	0.5	0.9	0.28	0.44	0.9
PMOS	6	0.27	1.9	0.48	0.9	0.22	0.32	0.9

$$C_j = \frac{C_{j0}}{\left(1 - \frac{V_D}{\phi_0}\right)^m}$$

C_{j0}

Channel-stop implant

N_A^+



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Linearizing the Junction Capacitance

Replace non-linear capacitance by **large-signal equivalent linear capacitance** which displaces **equal charge** over voltage swing of interest

$$C_{eq} = \frac{\Delta Q_j}{\Delta V_D} = \frac{Q_j(V_{high}) - Q_j(V_{low})}{V_{high} - V_{low}} = K_{eq} C_{j0}$$

$$K_{eq} = \frac{-\phi_0^m}{(V_{high} - V_{low})(1-m)} [(\phi_0 - V_{high})^{1-m} - (\phi_0 - V_{low})^{1-m}]$$



Example 5.3

	High-to-Low		Low-to-High	
	K_{eqb}	K_{eqsw}	K_{eqb}	K_{eqsw}
NMOS	0.57	0.61	0.79	0.81
PMOS	0.79	0.86	0.59	0.70

Junction Caps in 0.25 μm CMOS process

	C_{ox} (fF/ μm^2)	C_o (fF/ μm)	C_j (fF/ μm^2)	m_j	ϕ_b (V)	C_{jsw} (fF/ μm)	m_{jsw}	ϕ_{bsw} (V)
NMOS	6	0.31	2	0.5	0.9	0.28	0.44	0.9
PMOS	6	0.27	1.9	0.48	0.9	0.22	0.32	0.9



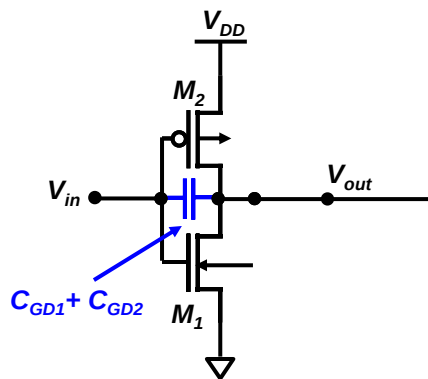
Table 3.5

```

simulator lang=spectre
model nmos bsim3v3
+version=3.1
+type =n
+tnom = 25          x1 = 3e-8
+xw   = 0           tox = 5.8e-9
...
+...               cj    = 2.024128e-3
+mj    = 0.4960069  pb    = 0.9173808  cjsw = 2.751528e-10
+mjsw  = 0.443145  pbsw  = 0.9173808  cjswg = 2.135064e-10
...
+cgdo  = 3.11e-10  cgso  = 3.11e-10  capmod = 0
...

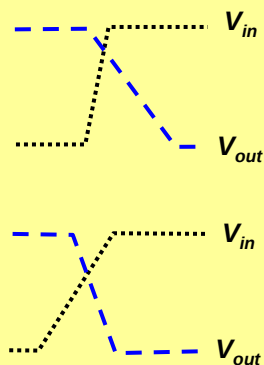
```

Gate-Drain Cap of Driving Inverter



- Non-constant voltage at either side of C_{GD}
- Needs to be accounted for during modeling
- Effect depends on relative slopes of V_{in} and V_{out}

Example waveforms



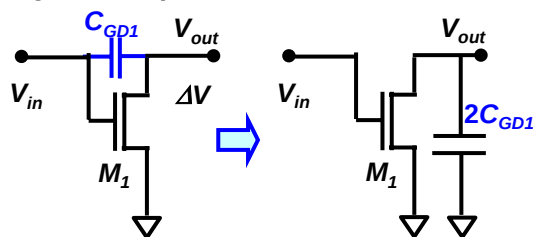
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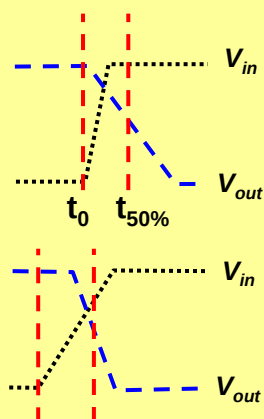
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Equivalent Grounded Drain Cap

- Effective voltage swing across capacitor is sum of swing of V_{in} and V_{out} in interval from t_0 to $t_{50\%}$
- For a ΔV swing on output, $\alpha \Delta V$ swing on input
- Effective swing $\sim (1+\alpha) \Delta V$
- $\alpha=1$ is usual approximation
- Coupling cap modeled as $2x$ ground cap



Example waveforms

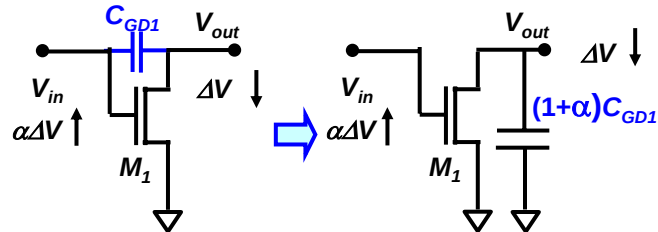


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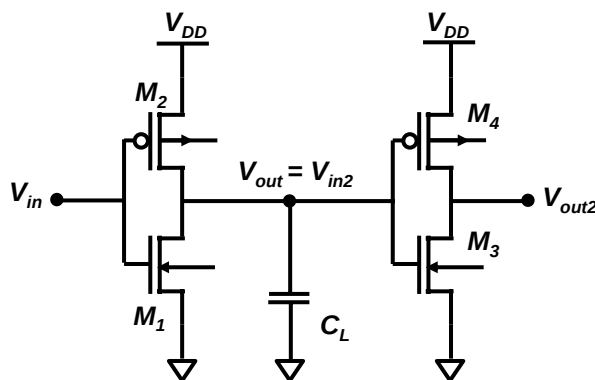
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Equivalent Grounded Drain Cap



- Typically, α is taken 1 (but it is only an approximation)
- This may remind you of the Miller effect in analog circuits
- But it is **not the same as the Miller effect**
- ...although it is sometimes denoted as 'digital Miller effect'

Lumped Capacitance Model Result

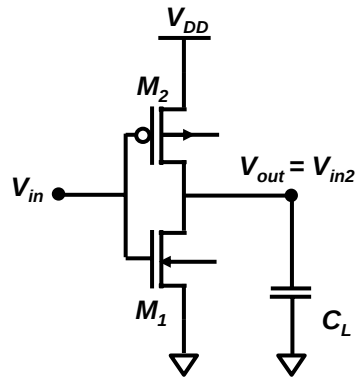


Sum of all Caps connected to Vout, with C_{GD} of driver counted twice to account for 'digital Miller effect'

$$C_L = 2(C_{GD1} + C_{GD2}) + C_{DB1} + C_{DB2} + C_{G3} + C_{G4} + C_w$$

$$(C_{G3} = C_{GS3} + C_{GD3} + C_{GB3}, C_{G4} = \dots)$$

(Dis)charge Time

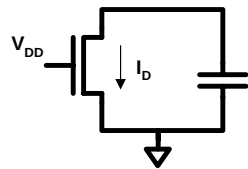


■ Use equivalent R_{on}
 $t_p = 0.69 R_{on} C_L$

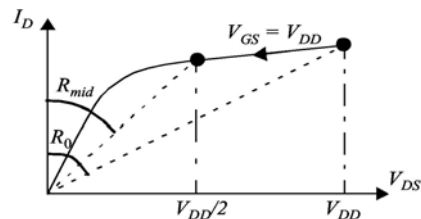
■ Or integrate transistor current

$$t_p = \int_{v_1}^{v_2} \frac{C_L}{i(v)} dv$$

Equivalent R_{on} (R_{eq})



(a) Schematic



(b) trajectory traversed on ID-VDS curve.

$$R_{eq} = \frac{1}{2} \left[\frac{V_{DD}}{I_{DSAT} (1 + \lambda V_{DD})} + \frac{V_{DD}/2}{I_{DSAT} (1 + \lambda V_{DD}/2)} \right]$$

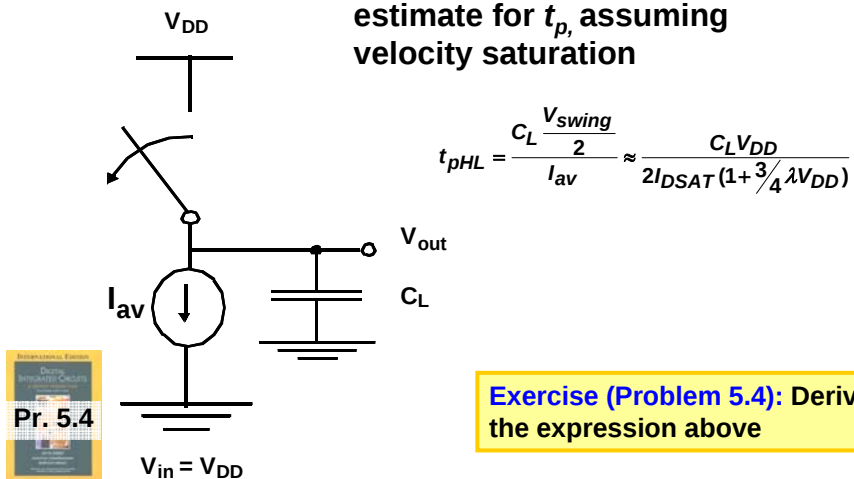
$$\approx \frac{3}{4} \frac{V_{DD}}{I_{DSAT}} \left(1 - \frac{5}{6} \lambda V_{DD} \right)$$



$$t_p \approx 0.69 \times \frac{3}{4} \frac{V_{DD}}{I_{DSAT}} \left(1 - \frac{5}{6} \lambda V_{DD} \right) C_L$$

Current Based Estimate for t_p

Alternative current-based estimate for t_p , assuming velocity saturation



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Comparison

With $V_{DD}=2.5$, $\lambda=0.06$:

$$t_p \approx 0.69 \times \frac{3}{4} \frac{V_{DD}}{I_{DSAT}} \left(1 - \frac{5}{6} \lambda V_{DD} \right) C_L \Rightarrow t_p \approx 1.13 \frac{C_L}{I_{DSAT}}$$

$$t_p \approx \frac{C_L V_{DD}}{2I_{DSAT} (1 + \frac{3}{4} \lambda V_{DD})} \Rightarrow t_p \approx 1.12 \frac{C_L}{I_{DSAT}}$$

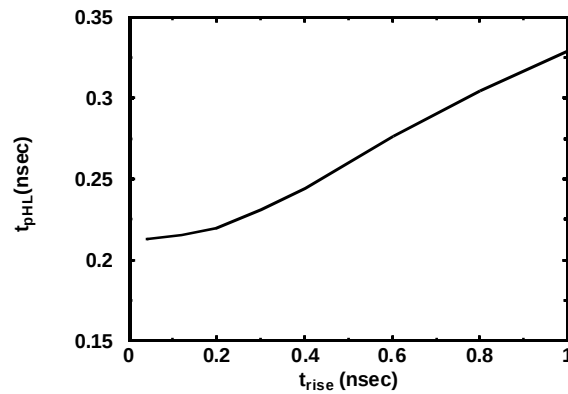


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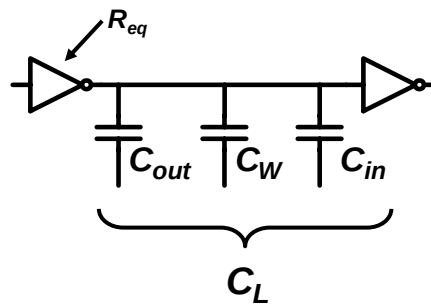
Impact of Rise Time on Delay



$$t_{pHL} = \sqrt{t_{pHL(step)}^2 + (t_r/2)^2}$$

Empirical from
the first edition of
book

Inverter Propagation Delay Summary

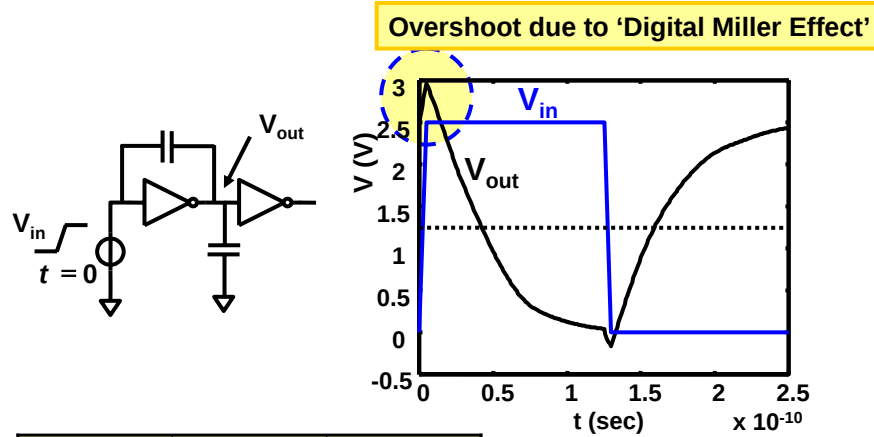


$$t_{pHL} = 0.69R_{eqn}C_L$$

$$t_{pLH} = 0.69R_{eqp}C_L$$

$$t_p = \frac{1}{2}(t_{pHL} + t_{pLH}) \quad \text{Propagation time}$$

Simulation Results



	analysis	simulation
t_{pHL} (ps)	36	39.9
t_{pLH} (ps)	29	31.7

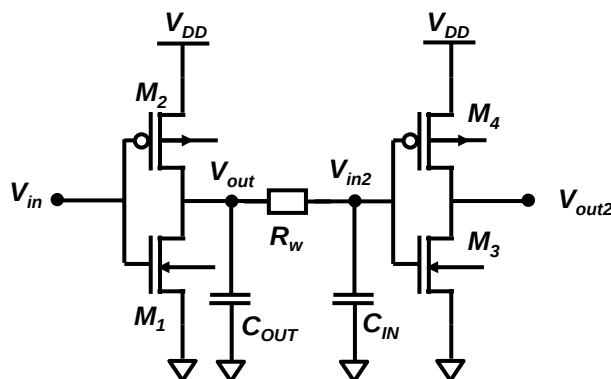
■ Good accuracy
■ Is in fact good luck

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Lumped Capacitance Model with Interconnect Resistance



$$C_{out} = 2C_{GD12} + C_{DB1} + C_{DB2} + C_w/2$$

$$C_{in} = C_{g3} + C_{g4} + C_w/2$$

$$t_{pHL} = 0.69R_{eqn}C_{out} + 0.69(R_{eqn} + R_W)C_{in}$$

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